

# International Rectifier

PD - 9.1125

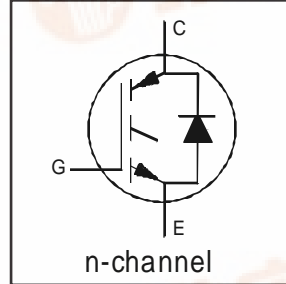
## IRGBC20KD2-S

INSULATED GATE BIPOLAR TRANSISTOR  
WITH ULTRAFAST SOFT RECOVERY DIODE

Short Circuit Rated  
UltraFast CoPack IGBT

### Features

- Short circuit rated -10µs @125°C,  $V_{GE} = 15V$
- Switching-loss rating includes all "tail" losses
- HEXFRED™ soft ultrafast diodes
- Optimized for high operating frequency (over 5kHz)  
See Fig. 1 for Current vs. Frequency curve

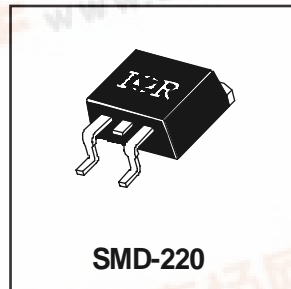


$V_{CES} = 600V$   
 $V_{CE(sat)} \leq 3.5V$   
@  $V_{GE} = 15V, I_C = 6.0A$

### Description

Co-packaged IGBTs are a natural extension of International Rectifier's well known IGBT line. They provide the convenience of an IGBT and an ultrafast recovery diode in one package, resulting in substantial benefits to a host of high-voltage, high-current, applications.

These new short circuit rated devices are especially suited for motor control and other applications requiring short circuit withstand capability.



### Absolute Maximum Ratings

	Parameter	Max.	Units
$V_{CES}$	Collector-to-Emitter Voltage	600	V
$I_C @ T_C = 25^\circ C$	Continuous Collector Current	10	A
$I_C @ T_C = 100^\circ C$	Continuous Collector Current	6.0	
$I_{CM}$	Pulsed Collector Current ①	20	
$I_{LM}$	Clamped Inductive Load Current ②	20	
$I_F @ T_C = 100^\circ C$	Diode Continuous Forward Current	7.0	
$I_{FM}$	Diode Maximum Forward Current	20	
$t_{sc}$	Short Circuit Withstand Time	10	µs
$V_{GE}$	Gate-to-Emitter Voltage	± 20	V
$P_D @ T_C = 25^\circ C$	Maximum Power Dissipation	60	W
$P_D @ T_C = 100^\circ C$	Maximum Power Dissipation	24	
$T_J$	Operating Junction and Storage Temperature Range	-55 to +150	°C
$T_{STG}$			
	Soldering Temperature, for 10 sec.	300 (0.063 in. (1.6mm) from case)	
	Mounting Torque, 6-32 or M3 Screw.	10 lbf•in (1.1 N•m)	

### Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case - IGBT	-----	-----	2.1	°C/W
$R_{\theta JC}$	Junction-to-Case - Diode	-----	-----	3.5	
$R_{\theta JA}$	Junction-to-Ambient, (PCB Mount)**	-----	-----	40	
$R_{\theta JA}$	Junction-to-Ambient, typical socket mount	-----	-----	80	
Wt	Weight	-----	2 (0.07)	-----	g (oz)

\*\* When mounted on 1" square PCB (FR-4 or G-10 Material)

For recommended footprint and soldering techniques refer to application note #AN-994.



# IRGBC20KD2-S



## Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

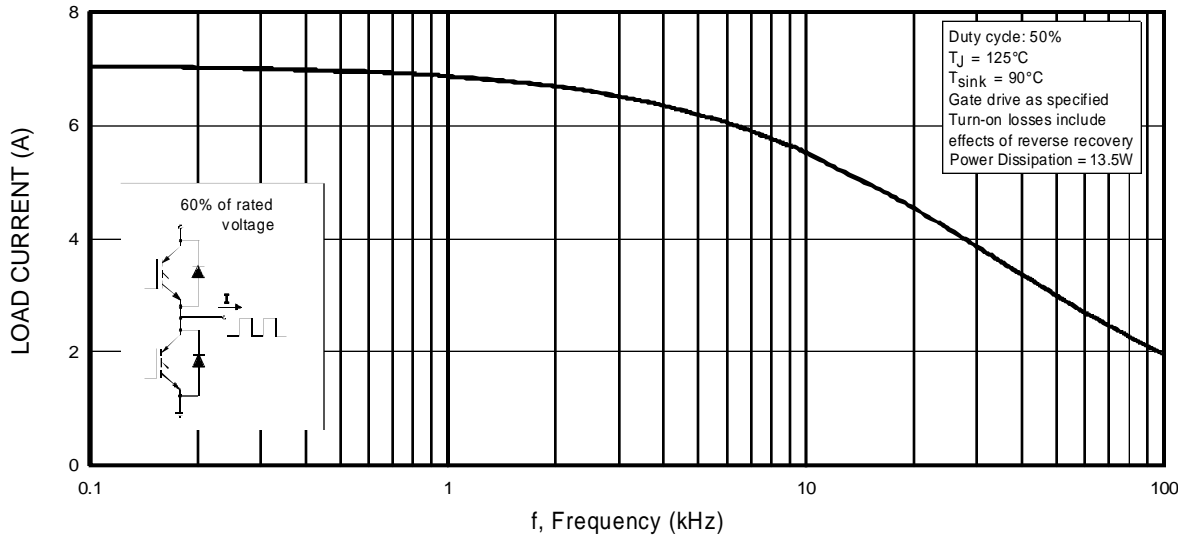
	Parameter	Min.	Typ.	Max.	Units	Conditions
V <sub>(BR)CES</sub>	Collector-to-Emitter Breakdown Voltage <sup>③</sup>	600	----	----	V	V <sub>GE</sub> = 0V, I <sub>C</sub> = 250μA
ΔV <sub>(BR)CES/ΔT<sub>J</sub></sub>	Temperature Coeff. of Breakdown Voltage	----	0.37	----	V/°C	V <sub>GE</sub> = 0V, I <sub>C</sub> = 1.0mA
V <sub>CE(on)</sub>	Collector-to-Emitter Saturation Voltage	----	2.4	3.5	V	I <sub>C</sub> = 6.0A V <sub>GE</sub> = 15V I <sub>C</sub> = 10A See Fig. 2, 5 I <sub>C</sub> = 6.0A, T <sub>J</sub> = 150°C
		----	3.6	----		
		----	2.8	----		
V <sub>GE(th)</sub>	Gate Threshold Voltage	3.0	----	5.5		V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 250μA
ΔV <sub>GE(th)/ΔT<sub>J</sub></sub>	Temperature Coeff. of Threshold Voltage	----	-11	----	mV/°C	V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 250μA
g <sub>fe</sub>	Forward Transconductance <sup>④</sup>	1.9	3.3	----	S	V <sub>CE</sub> = 100V, I <sub>C</sub> = 6.0A
I <sub>CES</sub>	Zero Gate Voltage Collector Current	----	----	250	μA	V <sub>GE</sub> = 0V, V <sub>CE</sub> = 600V
		----	----	1700		V <sub>GE</sub> = 0V, V <sub>CE</sub> = 600V, T <sub>J</sub> = 150°C
V <sub>FM</sub>	Diode Forward Voltage Drop	----	1.4	1.7	V	I <sub>C</sub> = 8.0A See Fig. 13 I <sub>C</sub> = 8.0A, T <sub>J</sub> = 150°C
		----	1.3	1.6		
I <sub>GES</sub>	Gate-to-Emitter Leakage Current	----	----	±100	nA	V <sub>GE</sub> = ±20V

## Switching Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

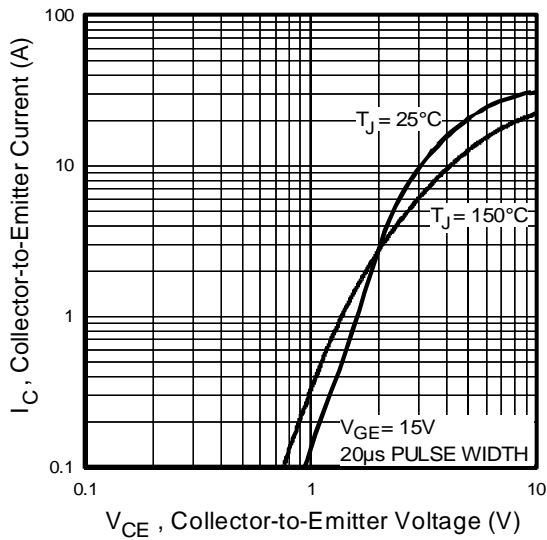
	Parameter	Min.	Typ.	Max.	Units	Conditions
Q <sub>g</sub>	Total Gate Charge (turn-on)	----	17	26	nC	I <sub>C</sub> = 6.0A V <sub>CC</sub> = 400V See Fig. 8
Q <sub>ge</sub>	Gate - Emitter Charge (turn-on)	----	4.3	6.8		
Q <sub>gc</sub>	Gate - Collector Charge (turn-on)	----	6.4	11		
t <sub>d(on)</sub>	Turn-On Delay Time	----	59	----	ns	T <sub>J</sub> = 25°C I <sub>C</sub> = 6.0A, V <sub>CC</sub> = 480V V <sub>GE</sub> = 15V, R <sub>G</sub> = 50Ω Energy losses include "tail" and diode reverse recovery.
t <sub>r</sub>	Rise Time	----	38	----		
t <sub>d(off)</sub>	Turn-Off Delay Time	----	110	210	mJ	See Fig. 9, 10, 11, 18
t <sub>f</sub>	Fall Time	----	80	120		
E <sub>on</sub>	Turn-On Switching Loss	----	0.28	----	μs	V <sub>CC</sub> = 360V, T <sub>J</sub> = 125°C V <sub>GE</sub> = 15V, R <sub>G</sub> = 50Ω, V <sub>CPK</sub> < 500V
E <sub>off</sub>	Turn-Off Switching Loss	----	0.15	----		
E <sub>ts</sub>	Total Switching Loss	----	0.43	0.90		
t <sub>sc</sub>	Short Circuit Withstand Time	10	----	----	ns	T <sub>J</sub> = 150°C, See Fig. 9, 10, 11, 18 I <sub>C</sub> = 6.0A, V <sub>CC</sub> = 480V V <sub>GE</sub> = 15V, R <sub>G</sub> = 50Ω Energy losses include "tail" and diode reverse recovery.
t <sub>d(on)</sub>	Turn-On Delay Time	----	52	----		
t <sub>r</sub>	Rise Time	----	35	----		
t <sub>d(off)</sub>	Turn-Off Delay Time	----	170	----		
t <sub>f</sub>	Fall Time	----	170	----		
E <sub>ts</sub>	Total Switching Loss	----	0.7	----	mJ	Measured 5mm from package
L <sub>E</sub>	Internal Emitter Inductance	----	7.5	----	nH	
C <sub>ies</sub>	Input Capacitance	----	350	----	pF	V <sub>GE</sub> = 0V V <sub>CC</sub> = 30V See Fig. 7 f = 1.0MHz
C <sub>oes</sub>	Output Capacitance	----	45	----		
C <sub>res</sub>	Reverse Transfer Capacitance	----	4.7	----		
t <sub>rr</sub>	Diode Reverse Recovery Time	----	37	55	ns	T <sub>J</sub> = 25°C See Fig. 14 T <sub>J</sub> = 125°C
		----	55	90		
I <sub>rr</sub>	Diode Peak Reverse Recovery Current	----	3.5	5.0	A	T <sub>J</sub> = 25°C See Fig. 15 T <sub>J</sub> = 125°C
		----	4.5	8.0		
Q <sub>rr</sub>	Diode Reverse Recovery Charge	----	65	138	nC	T <sub>J</sub> = 25°C See Fig. 16 T <sub>J</sub> = 125°C
		----	124	360		
μs			d <sub>(rec)</sub> /dt	Diode Peak Rate of Fall of Recovery	----	di/dt = 200A/ 240
----	A/μs	T <sub>J</sub> = 25°C	See Fig.	During t <sub>b</sub>	----	

### Notes:

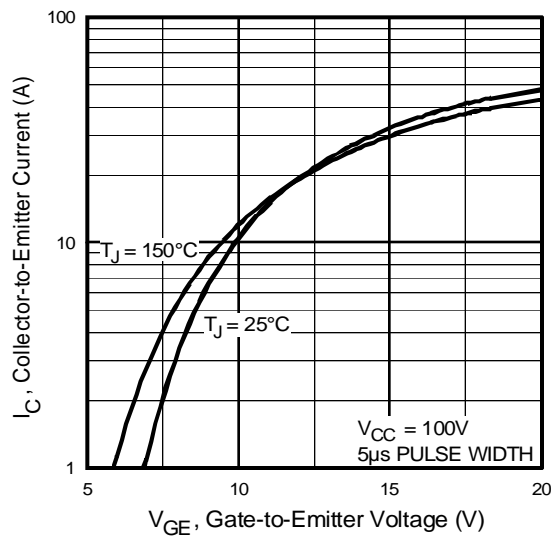
- ① Repetitive rating; V<sub>GE</sub>=20V, pulse width limited by max. junction temperature. ( See fig. 20 )
- ② T<sub>J</sub> = 125°C, V<sub>CC</sub>=80%(V<sub>CES</sub>), V<sub>GE</sub>=20V, L=10μH, R<sub>G</sub> = 50Ω, ( See fig. 19 )
- ③ Pulse width ≤ 80μs; duty factor ≤ 0.1%.
- ④ Pulse width 5.0μs, single shot.



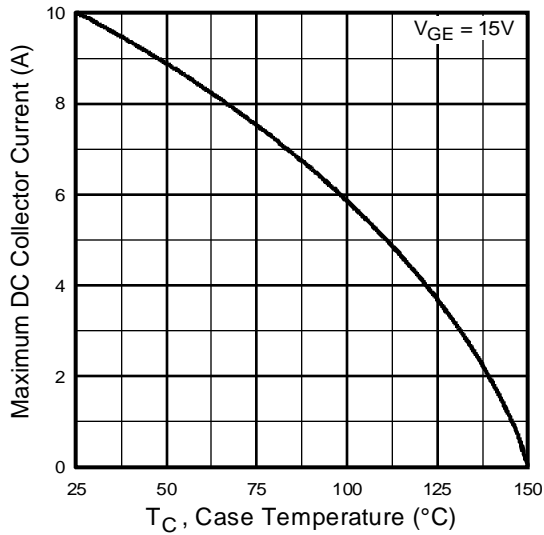
**Fig. 1 - Typical Load Current vs. Frequency**  
(Load Current =  $I_{RMS}$  of fundamental)



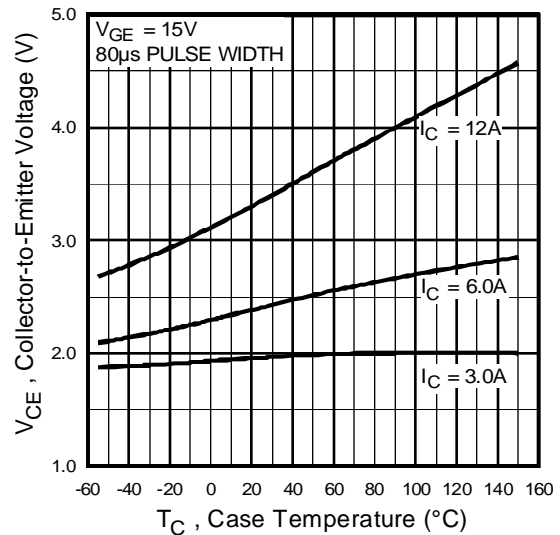
**Fig. 2 - Typical Output Characteristics**



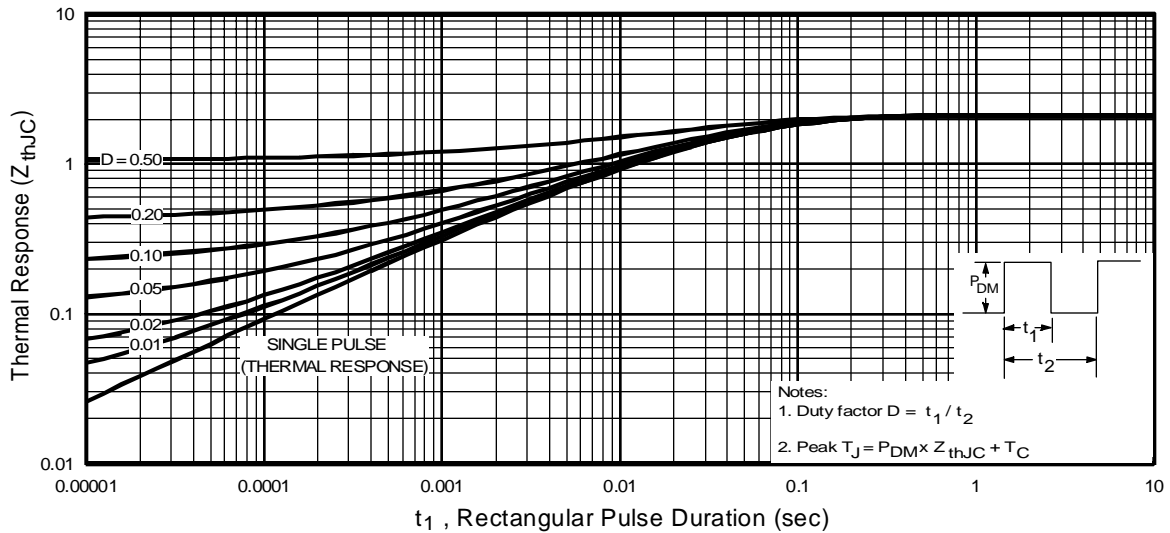
**Fig. 3 - Typical Transfer Characteristics**



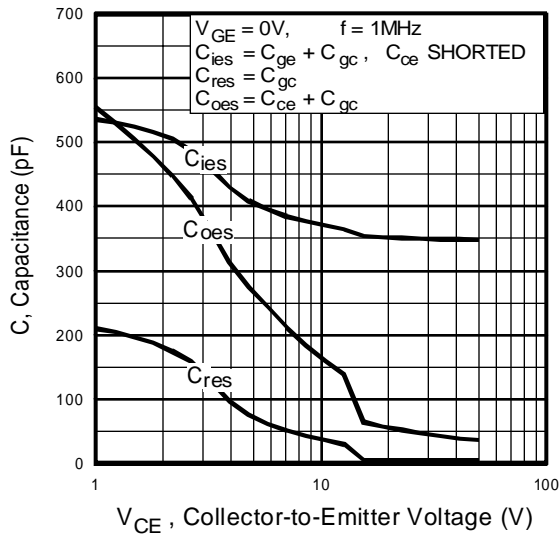
**Fig. 4** - Maximum Collector Current vs. Case Temperature



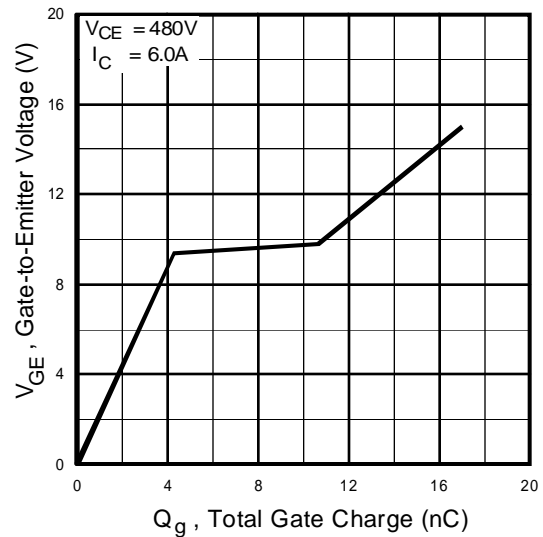
**Fig. 5** - Collector-to-Emitter Voltage vs. Case Temperature



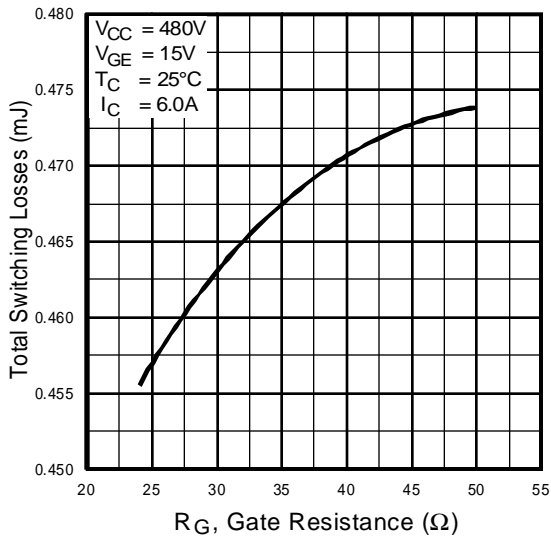
**Fig. 6** - Maximum IGBT Effective Transient Thermal Impedance, Junction-to-Case



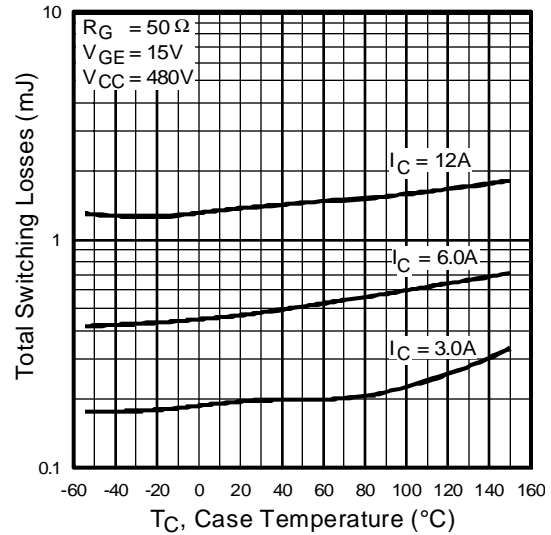
**Fig. 7** - Typical Capacitance vs. Collector-to-Emitter Voltage



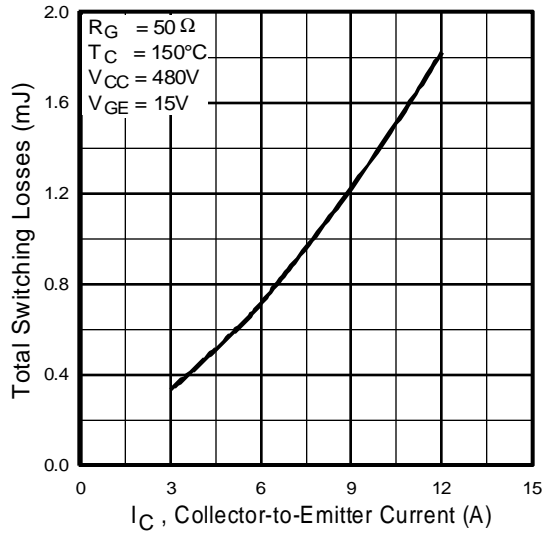
**Fig. 8** - Typical Gate Charge vs. Gate-to-Emitter Voltage



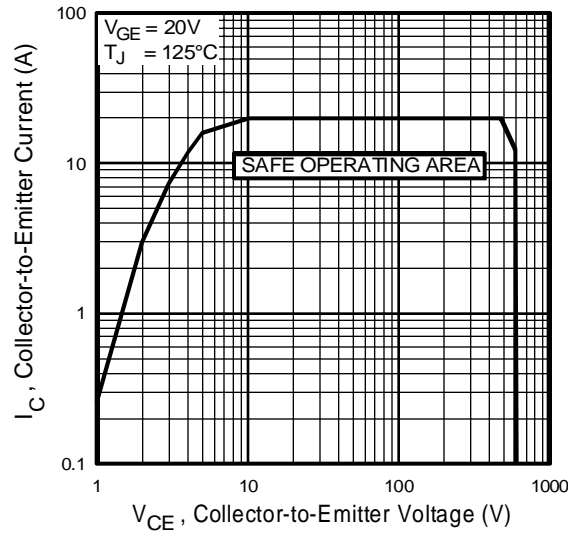
**Fig. 9** - Typical Switching Losses vs. Gate Resistance



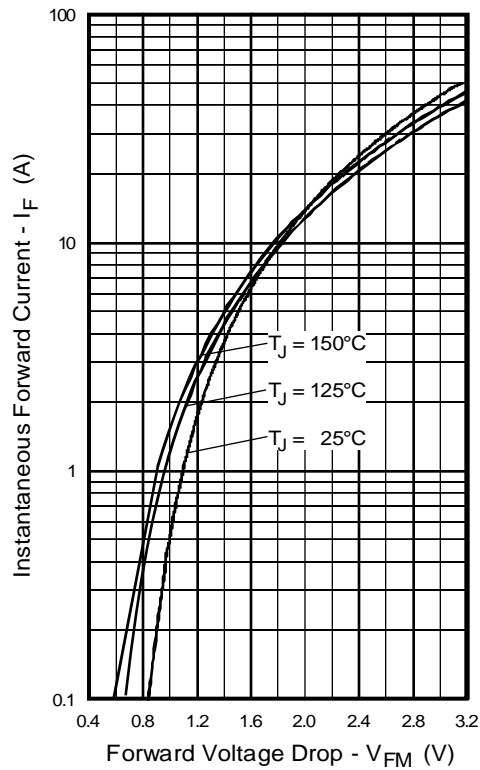
**Fig. 10** - Typical Switching Losses vs. Case Temperature



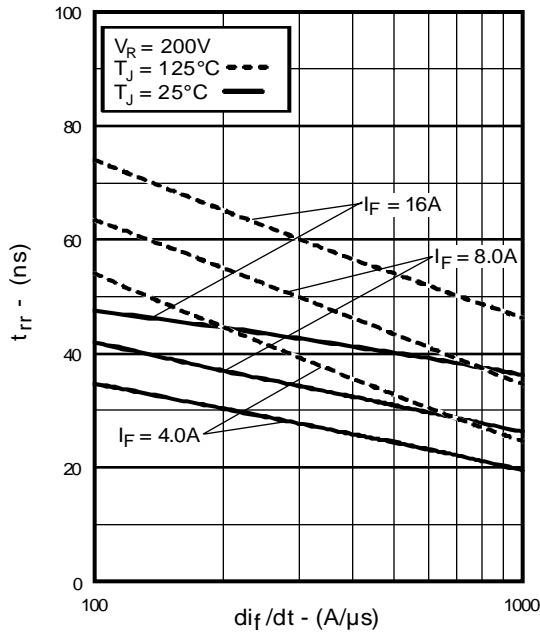
**Fig. 11** - Typical Switching Losses vs. Collector-to-Emitter Current



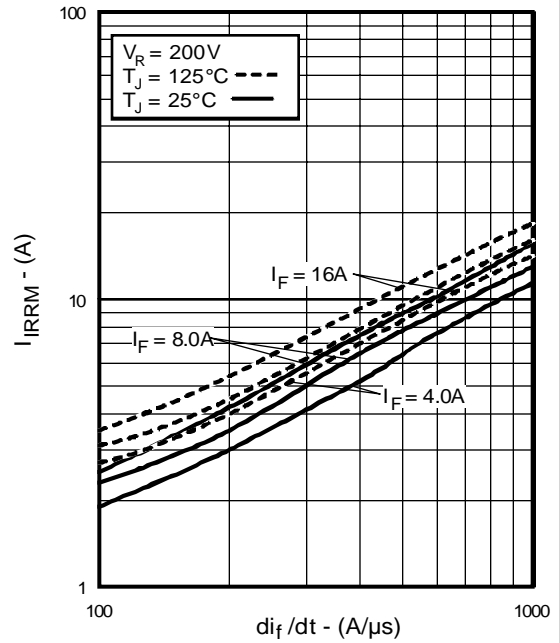
**Fig. 12** - Turn-Off SOA



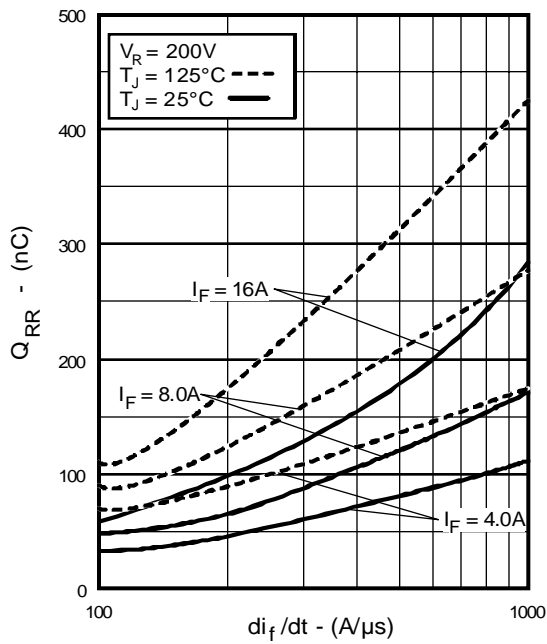
**Fig. 13** - Maximum Forward Voltage Drop vs. Instantaneous Forward Current



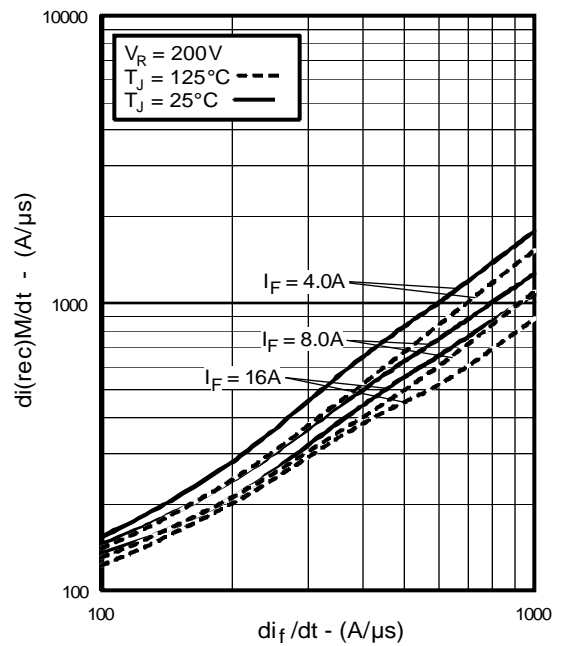
**Fig. 14** - Typical Reverse Recovery vs.  $di_f/dt$



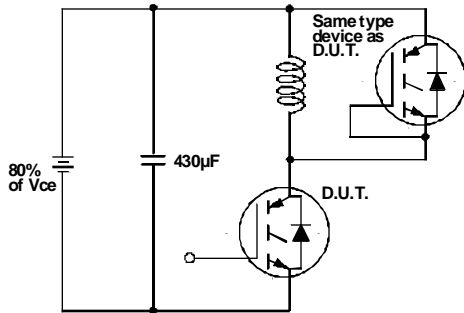
**Fig. 15** - Typical Recovery Current vs.  $di_f/dt$



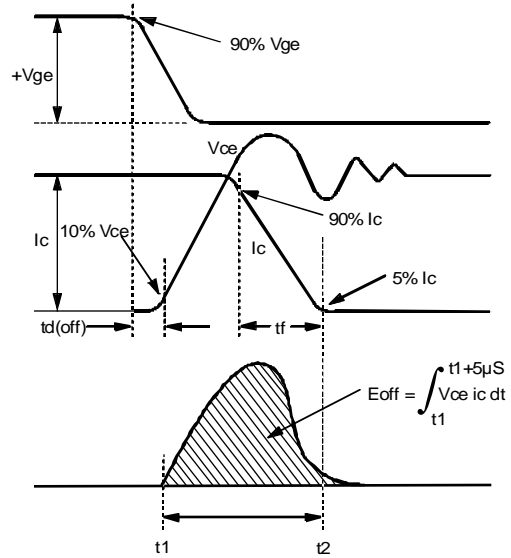
**Fig. 16** - Typical Stored Charge vs.  $di_f/dt$



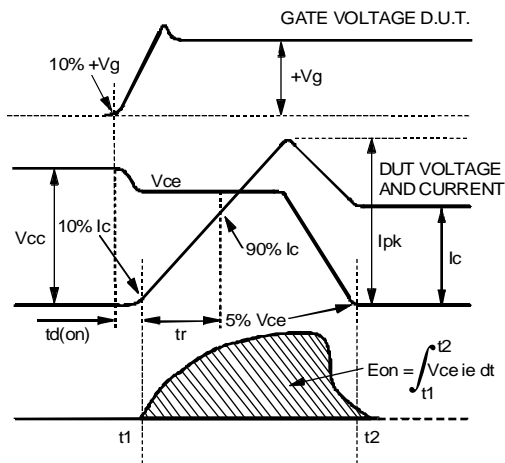
**Fig. 17** - Typical  $di_{(rec)M}/dt$  vs.  $di_f/dt$



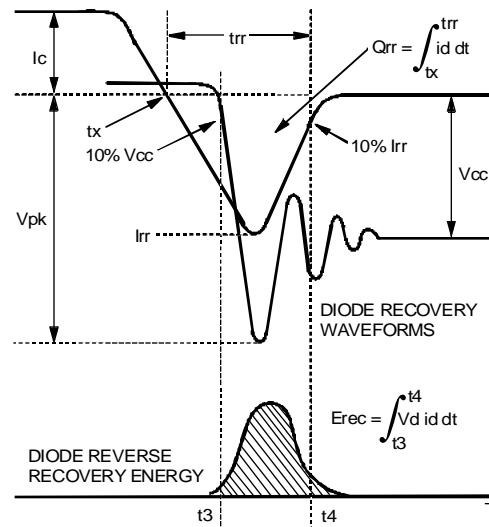
**Fig. 18a** - Test Circuit for Measurement of  $I_{LM}$ ,  $E_{on}$ ,  $E_{off}(\text{diode})$ ,  $t_{rr}$ ,  $Q_{rr}$ ,  $I_{rr}$ ,  $t_{d(on)}$ ,  $t_r$ ,  $t_{d(off)}$ ,  $t_f$



**Fig. 18b** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{off}$ ,  $t_{d(off)}$ ,  $t_f$



**Fig. 18c** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{on}$ ,  $t_{d(on)}$ ,  $t_r$

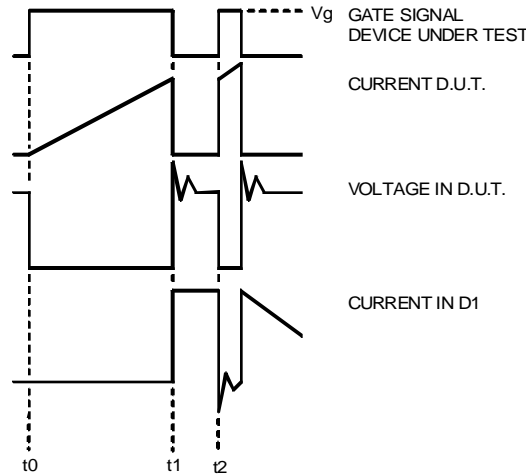


**Fig. 18d** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{rec}$ ,  $t_{rr}$ ,  $Q_{rr}$ ,  $I_{rr}$

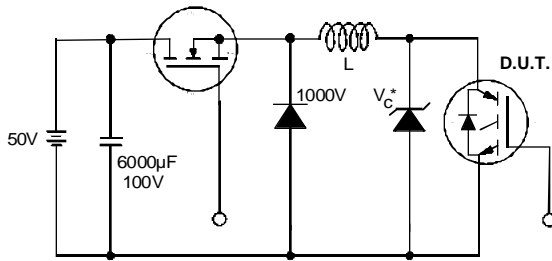




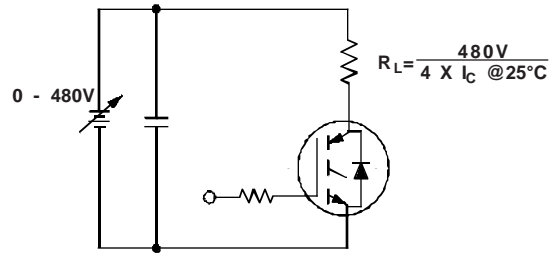
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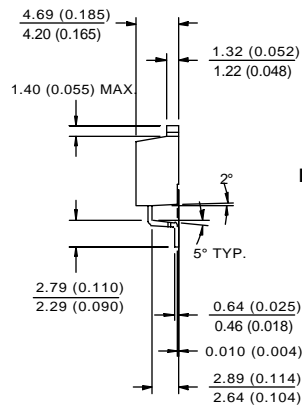
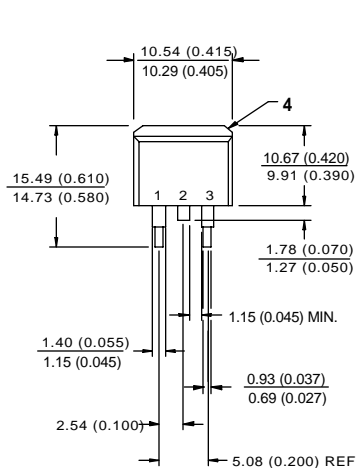
**Fig. 18e** - Macro Waveforms for Test Circuit of Fig. 18a



**Fig. 19** - Clamped Inductive Load Test Circuit



**Fig. 20** - Pulsed Collector Current Test Circuit



- LEAD ASSIGNMENTS**
- 1 - GATE
  - 2 - COLLECTOR
  - 3 - EMITTER
  - 4 - COLLECTOR

**OUTLINE SMD-220**  
Dimensions in Millimeters and (Inches)